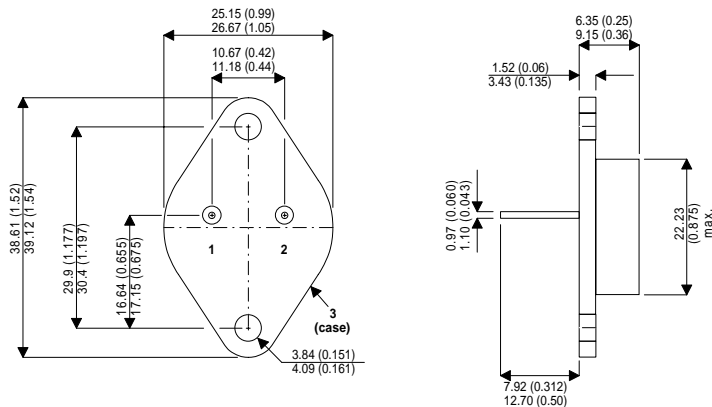


**MECHANICAL DATA**

Dimensions in mm

**ADVANCED  
DISTRIBUTED BASE DESIGN  
HIGH VOLTAGE  
HIGH SPEED NPN  
SILICON POWER TRANSISTOR**



**TO3 (TO-204AA)**

Pin 1 – Base      Pin 2 – Emitter      Case is Collector

- SEMEFAB DESIGNED AND DIFFUSED DIE
- HIGH VOLTAGE
- FAST SWITCHING
- HIGH ENERGY RATING
- EFFICIENT POWER SWITCHING
- MILITARY AND HI-REL OPTIONS
- EXCEPTIONAL HIGH TEMPERATURE PERFORMANCE

**FEATURES**

- Multi-base for efficient energy distribution across the chip resulting in significantly improved switching and energy ratings across full temperature range.
- Ion implant and high accuracy masking for tight control of characteristics from batch to batch.
- Triple Guard Rings for improved control of high voltages.

**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$  unless otherwise stated)

$V_{CBO}$	Collector – Base Voltage	600V
$V_{CEO}$	Collector – Emitter Voltage ( $I_B = 0$ )	300V
$V_{EBO}$	Emitter – Base Voltage ( $I_C = 0$ )	10V
$I_C$	Continuous Collector Current	40A
$P_{tot}$	Total Dissipation at $T_{case} = 25^{\circ}C$	200W
$T_{stg}$	Operating and Storage Temperature Range	-65 to 175°C
$R_{th}$	Thermal Resistance (junction-case)	0.75°C/W

Semelab Plc reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by Semelab is believed to be both accurate and reliable at the time of going to press. However Semelab assumes no responsibility for any errors or omissions discovered in its use. Semelab encourages customers to verify that datasheets are current before placing orders.

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**ELECTRICAL CHARACTERISTICS** ( $T_{case} = 25^{\circ}C$  unless otherwise stated)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit
<b>ELECTRICAL CHARACTERISTICS</b>					
$V_{CEO(sus)}$	Collector – Emitter Sustaining Voltage	$I_C = 100mA$ $I_B = 0$	300		
$V_{(BR)CBO}$	Collector – Base Breakdown Voltage	$I_C = 1mA$ $I_E = 0$	600		V
$V_{(BR)EBO}$	Emitter – Base Breakdown Voltage	$I_E = 1mA$ $I_C = 0$	10		
$I_{CBO}$	Collector – Base Cut-Off Current	$V_{CB} = 600V$ $I_E = 0$		10	$\mu A$
			$T_C = 125^{\circ}C$	100	
$I_{CEO}$	Collector – Emitter Cut-Off Current	$I_B = 0$ $V_{CE} = 300V$		100	$\mu A$
$I_{EBO}$	Emitter Cut-Off Current	$V_{EB} = 5V$ $I_C = 0$		10	$\mu A$
			$T_C = 125^{\circ}C$	100	
$h_{FE}^*$	DC Current Gain	$I_C = 1A$ $V_{CE} = 4V$	15		—
		$I_C = 10A$ $V_{CE} = 4V$	20		
		$I_C = 25A$ $V_{CE} = 4V$	25		
$V_{CE(sat)}^*$	Collector – Emitter Saturation Voltage	$I_C = 30A$ $I_B = 6A$		0.7	V
$V_{BE(sat)}^*$	Base – Emitter Saturation Voltage	$I_C = 10A$ $I_B = 1A$		1.1	
<b>DYNAMIC CHARACTERISTICS</b>					
$f_t$	Transition Frequency	$I_C = 100$ $V_{CE} = 4V$ $f = 10MHz$		20	MHz
$C_{ob}$	Output Capacitance	$V_{CB} = 20V$ $f = 10MHz$		260	pF

\* Pulse test  $t_p = 300\mu s$ ,  $\delta < 2\%$